

October 2012

FDM3622

N-Channel PowerTrench[®] MOSFET 100V, 4.4A, $60m\Omega$

Features

- Max $r_{DS(on)} = 60m\Omega$ at $V_{GS} = 10V$, $I_D = 4.4A$
- Max $r_{DS(on)} = 80m\Omega$ at $V_{GS} = 6.0V$, $I_D = 3.8A$
- Low Miller Charge
- Low QRR Body Diode
- Optimized efficiency at high frequencies
- UIS Capability (Single Pulse and Repetitive Pulse)
- RoHS Compliant

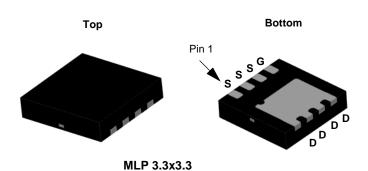


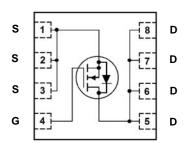
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

Applications

- Distributed Power Architectures and VRMs.
- Primary Switch for 24V and 48V Systems
- High Voltage Synchronous Rectifier
- Formerly developmental type 82744





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DS}	Drain to Source Voltage		100	V
V_{GS}	Gate to Source Voltage		±20	V
	Drain Current -Continuous	(Note 1a)	4.4	^
'D	-Pulsed		20	— A
D	Power Dissipation	(Note 1a)	2.1	W
P_{D}	Power Dissipation	(Note 1b)	0.9	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	3.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	60	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDM3622	FDM3622	Power 33	7"	8mm	3000 units

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V
l	Zero Gate Voltage Drain Current	$V_{DS} = 80V, V_{GS} = 0V$			1	μА
DSS	Zero Gate Voltage Drain Current	T _J = 100°C			250	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2		4	V
		$V_{GS} = 10V, I_D = 4.4A$		44	60	
r _{DS(on)} Static Drain to Source On Resistance	$V_{GS} = 6.0V, I_D = 3.8A$		56	80	$m\Omega$	
		$V_{GS} = 10V, I_D = 4.4A, T_J = 150^{\circ}C$		92	120	

Dynamic Characteristics

C _{iss}	Input Capacitance	V 25V V 0V	820	1090	pF
C _{oss}	Output Capacitance	V _{DS} = 25V, V _{GS} = 0V, f = 1MHz	125	170	pF
C _{rss}	Reverse Transfer Capacitance	-	35	55	pF
Rg	Gate Resistance	$V_{DS} = 15 \text{mV}, f = 1 \text{MHz}$	3.1		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			11	20	ns
t _r	Rise Time	$V_{DD} = 50V, I_{D} = 4.4A$ $V_{GS} = 10V, R_{GEN} = 24\Omega$		25	40	ns
t _{d(off)}	Turn-Off Delay Time			35	56	ns
t _f	Fall Time			26	42	ns
Qg	Total Gate Charge	V _{GS} = 10V		13	17	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DD} = 50V$		3.6		nC
Q _{gd}	Gate to Drain "Miller" Charge	I _D = 4.4A		3.4		nC

Drain-Source Diode Characteristics

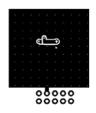
V _{SD} Source to Drain Diode Forward Voltage	Source to Drain Diode, Forward Voltage	$V_{GS} = 0V, I_{S} = 4.4A$		1.25	V
	$V_{GS} = 0V, I_{S} = 2.2A$		1.0	V	
t _{rr}	Reverse Recovery Time	I _F = 4.4A, di/dt = 100A/μs		56	ns
Q _{rr}	Reverse Recovery Charge			108	nC

Notes:

1: R_{0JA} is determined with the device mounted on a 1 in² oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0JA} is determined by the user's board design.

(a)R_{0JA} = 60°C/W when mounted on a 1 in² pad of 2 oz copper, 1.5'x1.5'x0.062' thick PCB.

(b)R_{0JA} = 135°C/W when mounted on a minimum pad of 2 oz copper.



a. 60°C/W when mounted on a 1 in² pad of 2 oz copper



b. 135°C/W when mounted on a minimum pad of 2 oz copper

2: Pulse Test: Pulse Width < 300μ s, Duty cycle < 2.0%.

Typical Characteristics $T_J = 25$ °C unless otherwise noted

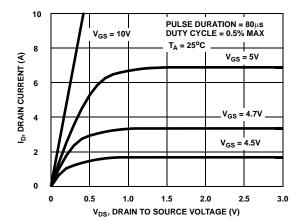


Figure 1. On-Region Characteristics

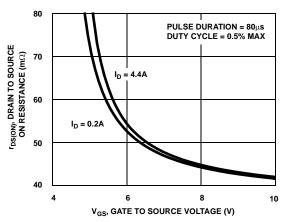


Figure 3. On-Resistance vs Gate to Source Voltage

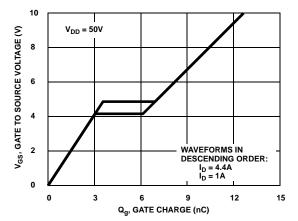


Figure 5. Gate Charge Characteristics

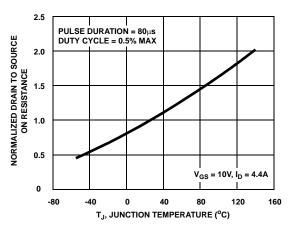


Figure 2. Normalized On-Resistance vs Junction Temperature

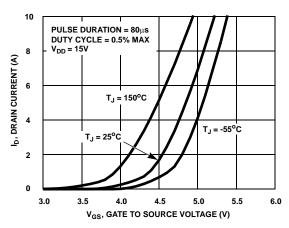


Figure 4. Transfer Characteristics

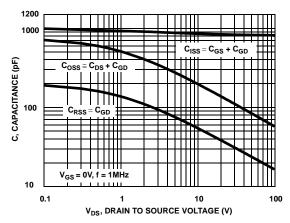


Figure 6. Capacitance vs Drain to Source Voltage

Typical Characteristics T_J = 25°C unless otherwise noted

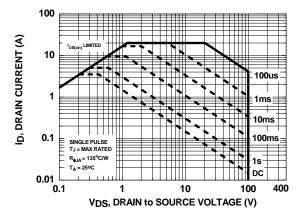


Figure 7. Forward Bias Safe Operating Area

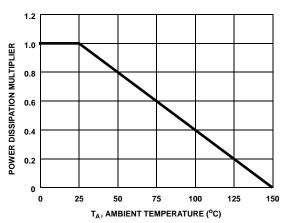


Figure 9. Normalized Power dissipation vs Ambient Temperature

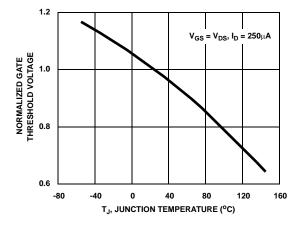


Figure 11. Normalized Gate Threshold voltage vs Junction Temperature

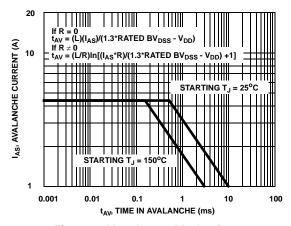


Figure 8. Uncalamped Inductive Switching Capability

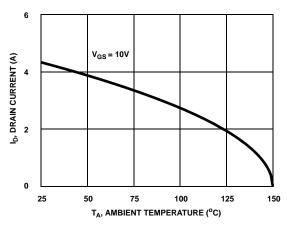


Figure 10. Maximum Continuous Drain Current vs Ambient Temperature

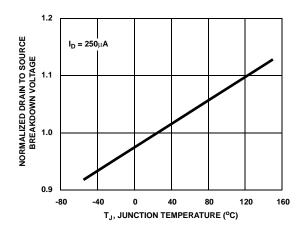


Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

Typical Characteristics $T_J = 25^{\circ}\text{C}$ unless otherwise noted

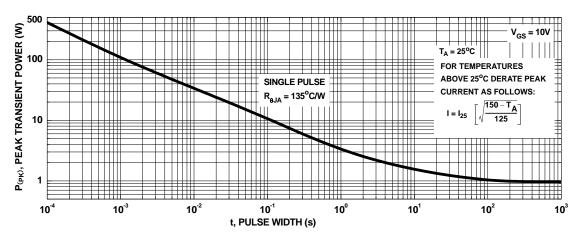


Figure 13. Peak Current Capability

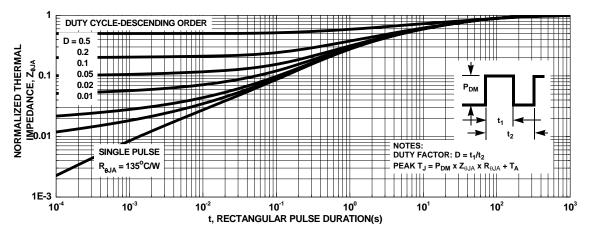
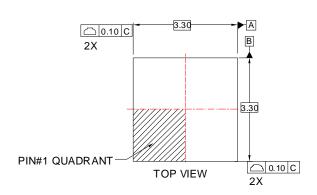
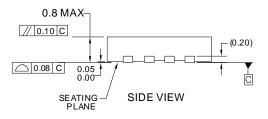
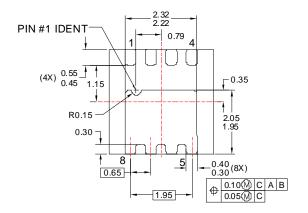


Figure 14. Transient Thermal Response Curve

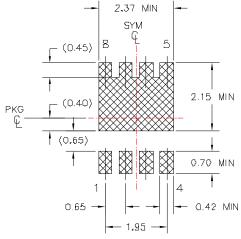
Dimensional Outline and Pad Layout







BOTTOM VIEW



RECOMMENDED LAND PATTERN

NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994
- D. LAND PATTERN RECOMMENDATION IS BASED ON FSC DESIGN ONLY
- E. DRAWING FILE NAME: MLP08Srev1





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